## Applicant(s)/Patent Under Application/Control No. Reexamination 10/542,974 HESSE, CHRISTIAN Notice of References Cited Examiner Art Unit Page 1 of 1 1765 Kin-Chan Chen **U.S. PATENT DOCUMENTS** Date **Document Number** \* Name Classification Country Code-Number-Kind Code MM-YYYY US-2002/0011919 01-2002 338/23 Ito et al. \* US-2002/0003557 01-2002 Miyakoshi et al. 347/58 В \* US-7,245,479 07-2007 Kobayashi et al. 361/523 С \* US-6,522,237 02-2003 Ito et al. 338/22R D US-6,475,604 11-2002 Fujii et al. 428/209 Ε 01-2001 Inoue et al. 338/22R F US-6,172,592 06-2003 US-2003/0112116 Fujimoto et al. 336/200 G 07-2002 257/777 US-2002/0089065 Fujimoto et al. Н US-US-US-Κ US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν O Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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